

## THERMAL MODELING FOR ON-INTERPOSER THERMOELECTRIC SENSORS

## OBJECTIVES

- Our aim is to design micro ThermoElectric Sensors ( $\mu$ TES) to detect hot spots in microelectronic devices.
- Use of the Seebeck effect which produces a voltage signal when the  $\mu$ TES is placed in a thermal gradient.
- A  $\mu$ TES is made of a large number of positive Seebeck coefficient lines (p-lines) connected to the same number of negative Seebeck coefficient lines (n-lines) to form p-n junctions.
- $\mu$ TES are placed in-between a thermal test chip (TTC acting as a hot source) and a Si-based wafer which may be etched (or not) to integrate micro-channels for cooling by air or water
- The goal is to attain a sensitivity  $Se = 100 \text{ mV}/^\circ\text{C}$  with a short response time ( $< 400 \text{ ms}$ ).

# THERMOELECTRICITY GOVERNING EQUATIONS (JAEGLER, 2007)

- Equation for the temperature T:

$$\rho C \frac{\partial T}{\partial t} + \nabla \cdot \underline{q} = Q$$

$$\underline{q} = -k \nabla T + \underbrace{S}_{\text{Seebeck coefficient}} T \underbrace{\underline{J}}_{\text{electric current density}}$$

$$\underbrace{Q}_{\text{Joule heat source}} = \underline{J} \cdot \underline{E} \quad \underline{E} = -\nabla U$$

- Electric current density (A/m<sup>2</sup>):

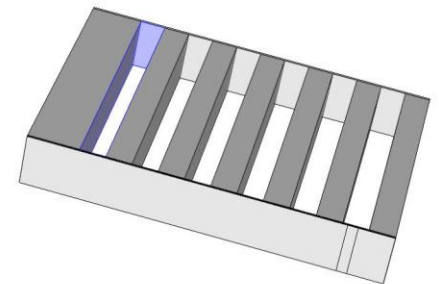
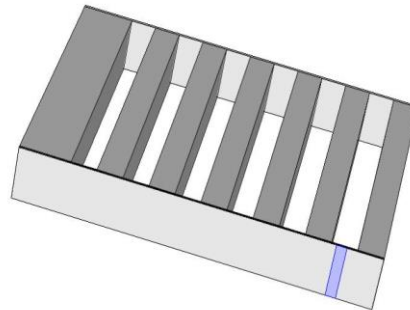
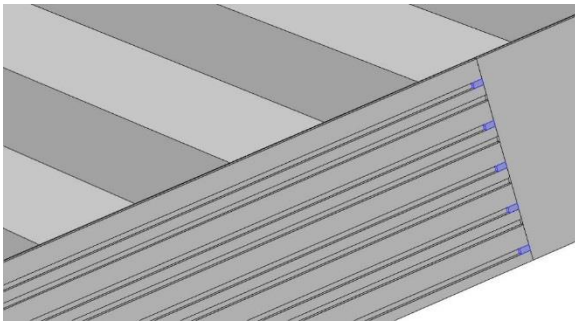
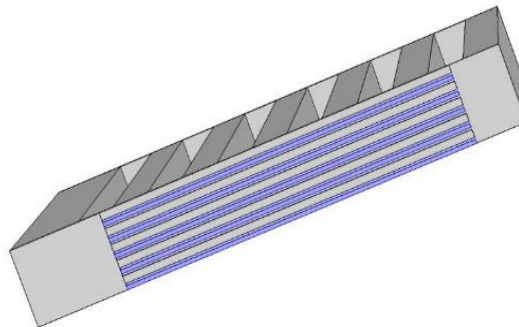
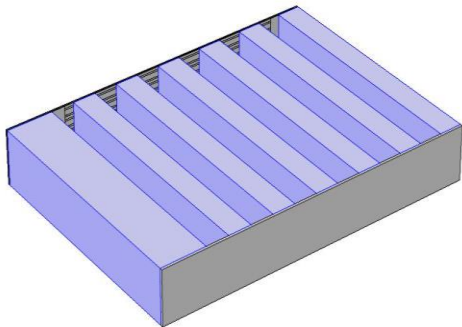
$$\underline{J} = - \underbrace{\sigma}_{\text{electrical conductivity}} (\nabla U + S \nabla T)$$

- Equation for the electric potential U (V):

$$\underbrace{\epsilon}_{\text{permittivity}} \left[ \frac{\partial^2 U}{\partial x^2} + \frac{\partial^2 U}{\partial y^2} + \frac{\partial^2 U}{\partial z^2} \right] = -\nabla \cdot \underline{J}$$

## GEOMETRICAL MODEL OF $\mu$ TES AND MICRO-CHANNELS

- Only 5 junctions (10 lines) of the  $\mu$ TES are simulated (the complete  $\mu$ TES has 315 junctions which is not manageable by the simulation because of small details like silicides)
- Six micro-channels are simulated when they are present.



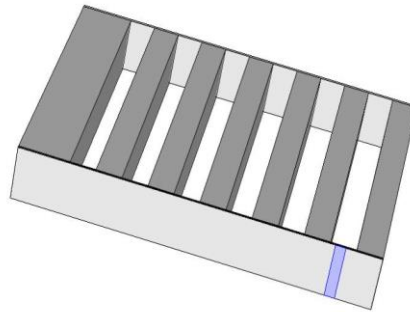
## MATERIAL PROPERTIES OF THE P-N LINES

- Two different thermoelectric materials are tested: SiGe (Silicium Germanium alloy) and QDSL (Quantum Dot SuperLattices).
- Definition of parameters used

Materials	SiGe		QDSL	
Line type	p	n	p	n
$R = 1/\sigma$ ( $\Omega.m$ )	$3.10^{-5}$	$3,4.10^{-5}$	$1,6.10^{-4}$	$2,5.10^{-4}$
S (mV/K)	142	-185	253	-267
k (W/mK)	4.7	4.1	5.3	6.3
$\rho$ ( $kg/m^3$ )	2330	2330	2330	2330
C (J/kgK)	710	710	710	710

## SIMULATION CASES

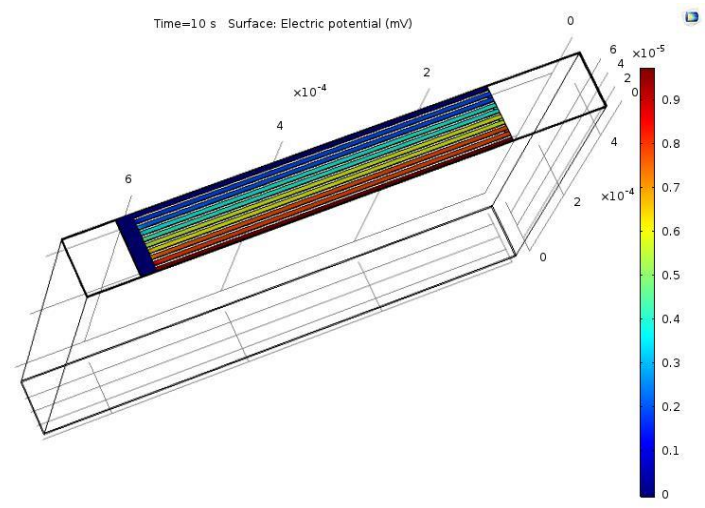
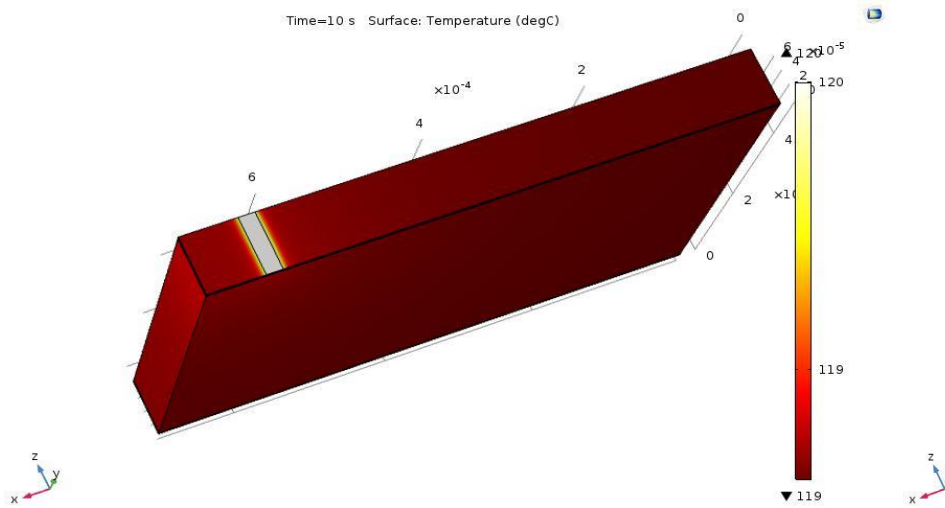
- We investigate two types of heat transfer boundary conditions:
  - > Imposed temperature = 120 °C
  - > Imposed flux density =  $P/S = 99469 \text{ W/m}^2$



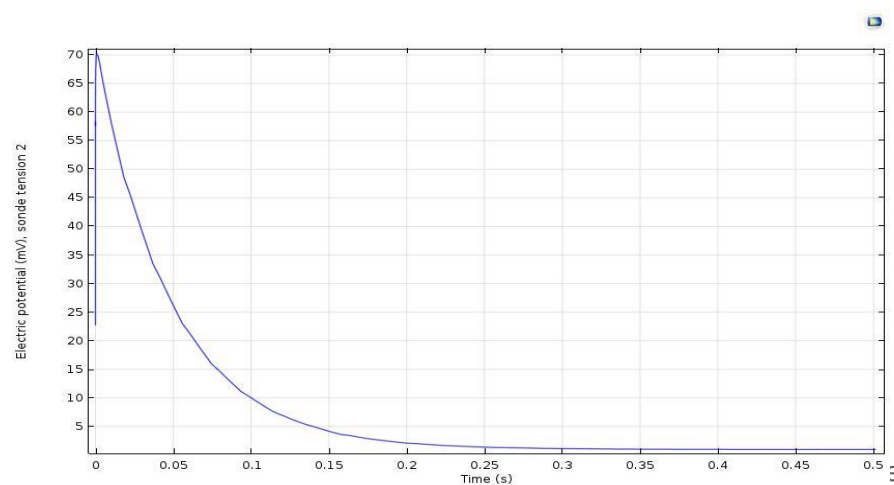
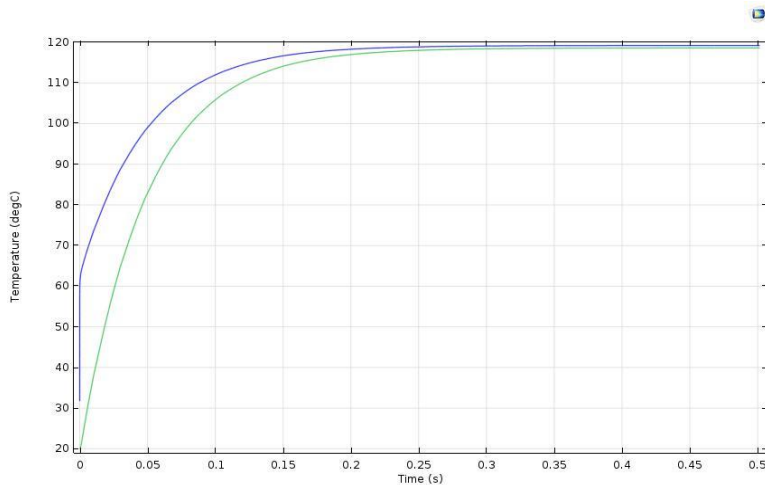
- Calculations with and without micro-channels are made in order to investigate the cooling effect.

# IMPOSED TEMPERATURE WITHOUT MICRO-CHANNELS SIGE MATERIAL

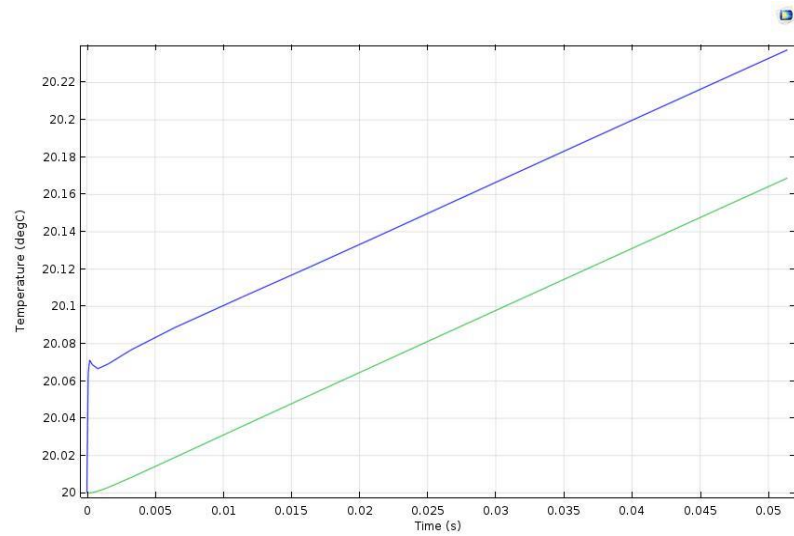
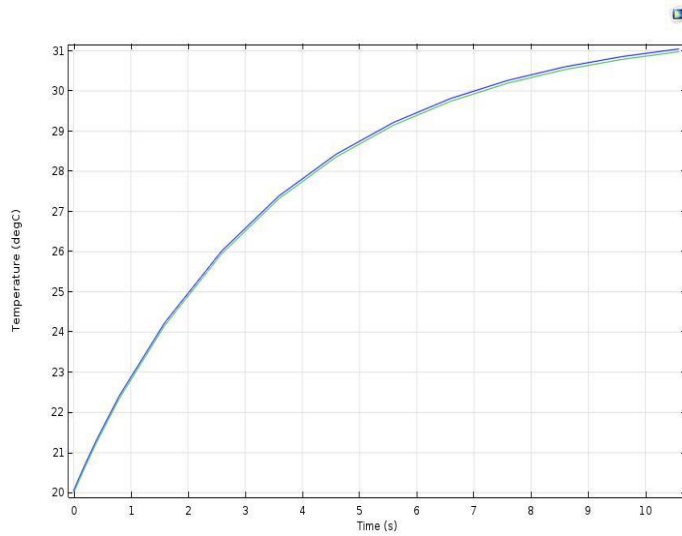
- Temperature and electric fields at the end of the calc. (t = 10 s)



- Time evolution of the hot and cold sides temperatures and the U

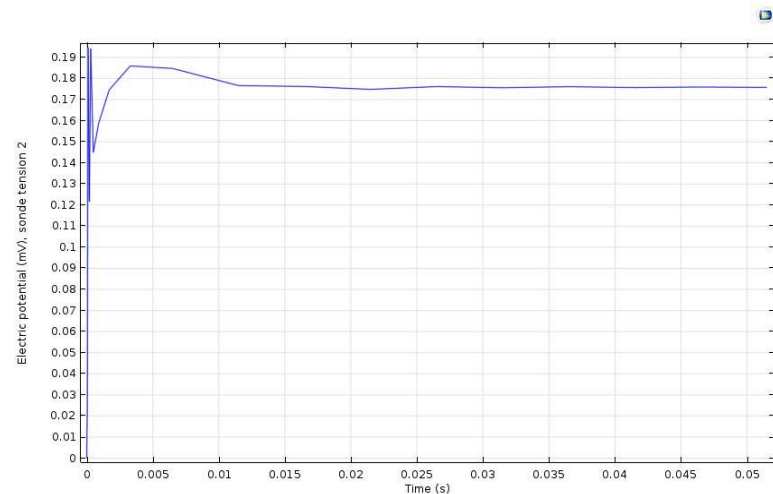
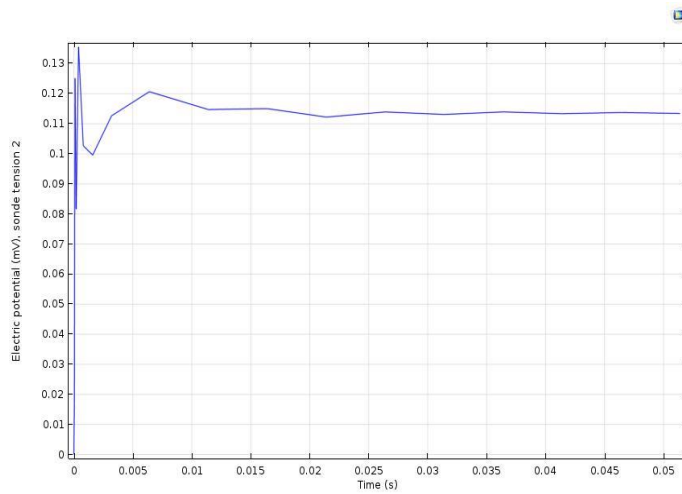


# IMPOSED FLUX WITHOUT MICRO-CHANNELS SIGE AND QDSL MATERIALS



● **Left: SiGe**

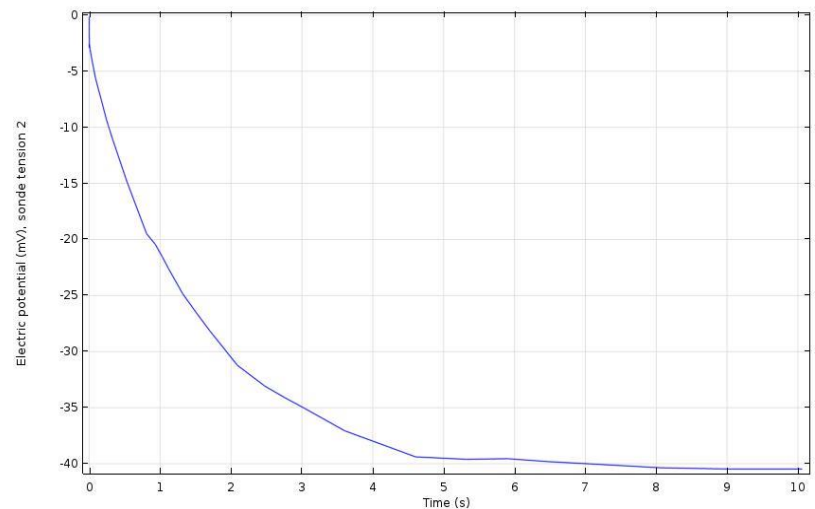
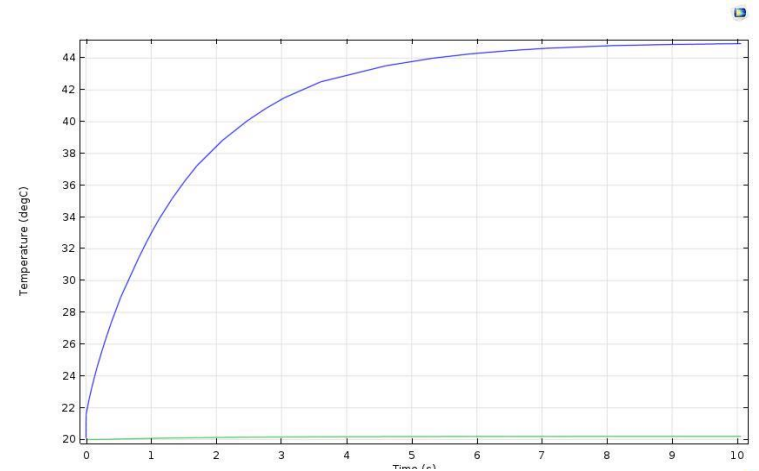
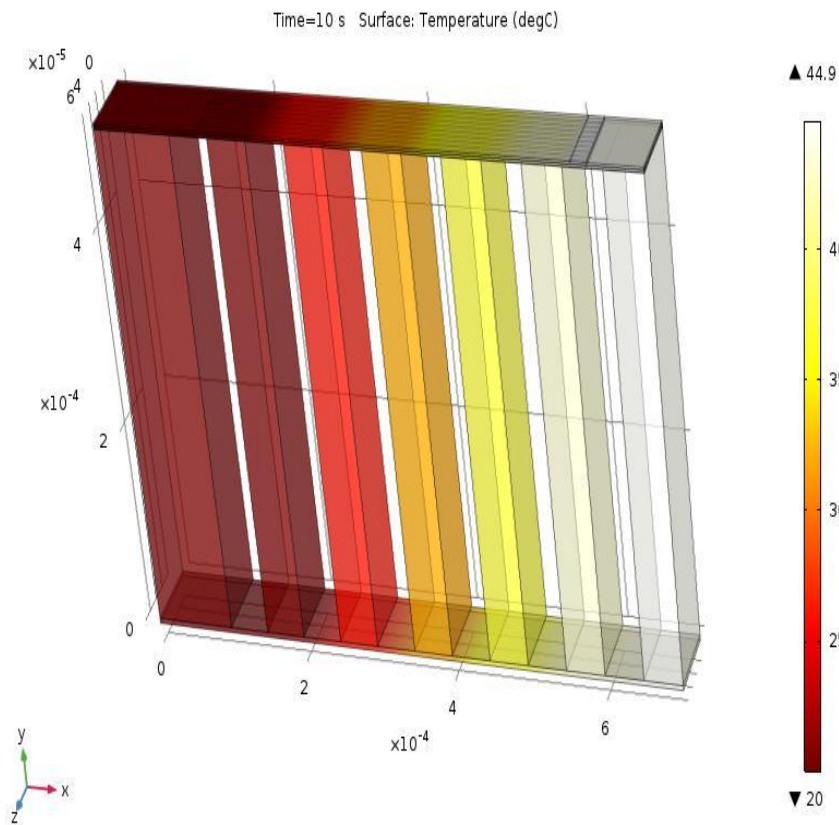
**Right: QDSL**





# EFFECT OF THE CHANNELS SIZE AND IMPOSED HEAT FLUX

- 5 micro-channels filled with air ( $h = 15 \text{ W/m}^2\text{K}$ ) and 1 with water ( $h = 10000 \text{ W/m}^2\text{K}$ )



# CALCULATION OF THE SENSITIVITY IN THE DIFFERENT CASES

Materials	heat transfer boundary conditions	$\mu$ channels	Temperature difference $\Delta T = T_h - T_c$ (K)	Voltage U (mV)	Time t (s)	Sensitivity Se (mV/K) 5 junctions	Sensitivity Se (mV/K) 315 junctions
SiGe	120 °C	no	43	70	0.01 s	1.63	103
QDSL	120 °C	no	43	112	0.01 s	2.6	164
SiGe	flux	no	0.072	0.12	0.001	1.66	105
QDSL	flux	no	0.072	0.19	0.001	2.64	166
SiGe	flux	yes	25	41	5	1.64	103

- **SiGe: 102.6 mV/K < Se < 105 mV/K for 315 junctions**
- **QDSL: 164 mV/K < Se < 166 mV/K for 315 junctions**
- **QDSL has a better performance due to its higher Seebeck coefficient**

## CONCLUSIONS

- The  $\mu$ TES sensitivities  $S_e$  are always greater than the 100 mV/K required
- The response time varies with the temperature field predictions: a rapid temperature variation will give a quick response time



- EUROPEAN UNION

The research leading to some of these results has been performed within the STREAMS project ([www.project-streams.eu](http://www.project-streams.eu)) and received funding from the European Union's Horizon 2020 program under Grant Agreement n° 688564



STREAMS

Smart Technologies for eneRgy Efficient Active  
cooling in Advanced Microelectronic Systems

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